<u>Lecture</u> 8

Recup - ANOVA & Multiple Testing

ANOVA: - Cell means molel:

yij ~ N(μi, σ²) i=1,..., κ

- We used an F-test

F= MSE between

MSE within

compans ons:

- We can check differences between individual groups

$$t = \frac{\bar{y}_{i.} - \bar{y}_{\ell.}}{S\sqrt{\frac{1}{n_{i}} + \frac{1}{n_{\ell}}}} \sim t_{n-k}$$

$$S^{2} = \frac{SS_{\ell.}}{n-k} = \frac{SS_{within}}{n-k}$$

- he can also cheen contrasts:

$$t = \frac{\sum_{i=1}^{u} \lambda_{i} \overline{y}_{i}}{\sum_{i=1}^{u} \frac{\lambda_{i}}{n_{i}}} \qquad \sum_{i=0}^{u} \sum_{j=0}^{u} \sum_{i=1}^{u} \lambda_{i}^{2} \neq 0$$

Muliple Companisons

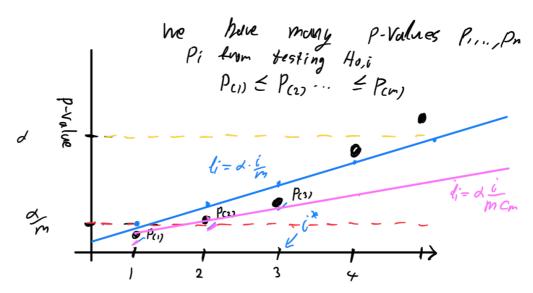
Goal: find which groups are

motivating rejection of alobal null

- This requires us to test "jointly" a family of null hypotheses sho, is the intrust)
- Bonferronis union bound;
 set significance level in each
 test to be 2/m
- Bonferronis method guaranteec

 Pol reject something all Hoic ure

 true
- However, This, can be too conservative", nearing you may not reject some non nulls,



False-Discovery Rate (FDR)

= Suppose we make m hypotheses tests

2 Ho, i 3i=1. Each has either rejeted or not.

We summarize the Gituation in a table:

not rej. # rej. Total

Ho, i firue 1) / Mo

	<u> </u>	v	
Ho,i false	+	S	m,
Total	m-R	R	m

- Del. fulse discovery rete is
ECFDPJ

FDR controlling using Benjamini & Hoschberg

- Perform each test; sort the P-Values from lowest to highest PCD = ... Pcm
- Define li= d. in (line with shipe d)
- Define ix = max ?i; pci) eli}
- Reject all Ho, i Pisé Pci*)

Theorem (BH '95)

If all p-values are injectment, then $FDR
eq
\frac{m_0}{m}
ot
ot
ot$

FDP with w/o independence assumption

- If the tests statistics satisfy

"positive regression dependency"

(PRI) Item By procedure

still controls FDR at level d. (Benjamini & Yeuntieli '01) PRD: For any increasing set D $Pr(X \in D | X_1 = x_1, ..., X_n = x_n)$ is non-decreasing in x,...xn (χ_1,χ_2) $D = ((t_1, n)_X(t_1, b))$ to - D (x, x1) Under general depency structure:

Under general depency structure:

- we should be more conservative

- we use $l_i = d \frac{i}{m} \cdot \frac{l}{c_m}$ $c_m = \sum_{i=1}^{m} \frac{l}{i} \approx ln(m) + pr - \frac{l}{2m} \approx lun$ Fuler 20.57

Constant

Simple Regression
(xi, yi) & Ri

- Regression line:

$$\mathbb{E}(Y|X=x) = \mu_y + p \frac{\sigma_y}{\sigma_x}(x-\mu_x)$$

- The "45" degree" line

$$y(x) = y_y + \frac{\sigma_y}{\sigma_x}(x - y_x)$$

- Regression to the mean effect

The linear Mobel:

$$\mathcal{Y}_{i} = \beta_{0} + \beta_{1} x_{i} + \varepsilon_{i}$$

$$\mathcal{Z} = \begin{pmatrix} 1 & x_{i} \\ \vdots & \vdots \\ 1 & x_{n} \end{pmatrix} \qquad p = \begin{pmatrix} \beta_{0} \\ \beta_{i} \end{pmatrix} \qquad \beta = (Z^{T} Z)^{T} Z^{T} Y$$

We have: $\hat{\beta}_{i} = \frac{\sum_{i=1}^{n} (x_{i} - \bar{x})y_{i}}{\sum_{i=1}^{n} (x_{i} - \bar{x})^{2}} = \frac{\sum_{i=1}^{n} (x_{i} - \bar{x})y_{i}}{\sum_{i=1}^{n} (x_{i} - \bar{x})^{2}}$ and

and $\hat{\beta}_0 = \bar{y} - \hat{\beta}, \bar{x}$

Proof: HWS

Variance of B

Vortance of B,

- When
$$\varepsilon_i \stackrel{iid}{\sim} N(0, \sigma^2) \iff Y_i \stackrel{jid}{\sim} N(\beta_0 + \beta_i X_i, \gamma_i)$$

 $Var(\hat{\beta}_i) = Var \left[\frac{\sum_{i=1}^{n} (x_i - \bar{x}_i) Y_i}{2} \right] = \sum_{i=1}^{n} Var((x_i - \bar{x}_i))$

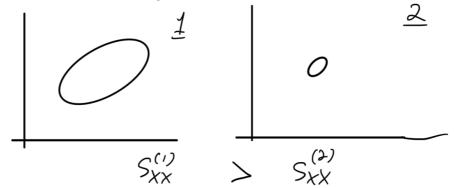
$$= \left(\sum_{i=1}^{S_{xx}} \frac{(x_i - \bar{x})^2}{S_{xx}^2} \right)^{Vav(Y_i)} = \frac{\sigma^2}{S_{xx}} = \frac{\sigma^2}{\frac{N}{N} \left(\frac{1}{N} \sum_{i=1}^{N} (x_i - \bar{x})^2)} S_{xx}$$

What affects $Var(\beta_i)$:
$$S_{xx}$$

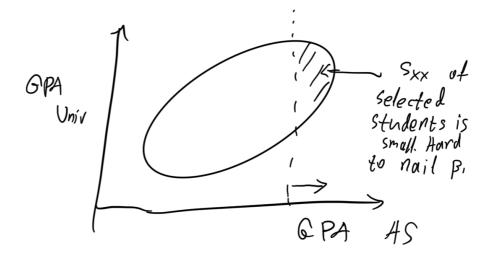
- or (increases with)

- n (decreases with)

-
$$S_{xx} = \frac{1}{5} \sum_{i=1}^{n} (x_i - \bar{x})^2$$
 Measures
in the data.



admission threshold

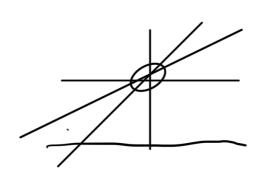


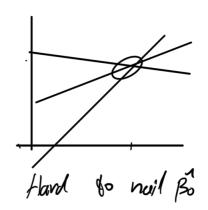
Variance in Bo

$$Var(\beta_0) = \dots = \frac{\sigma^2}{n} \frac{\frac{1}{n} \sum_{i=1}^{n} x_i^2}{S_{xx}}$$

. .

tends to be large when we are dealing with large values of X that have small S_{xx}





Variance of
$$\beta_0 + \beta_1 x$$

- he have
$$E(Y|X=x) = \beta_0 + \beta_1 x = x$$

- Ve hove:

$$Var(\hat{\beta_0} + \hat{\beta_1}x) = \dots = \frac{\sigma^2}{n} \left[1 + \left[\sqrt{n} \frac{x - \hat{x}}{\sqrt{s_{xx}}} \right]^2 \right]$$

- $\frac{x-\bar{x}}{\sqrt{s_{xx}}}$ measures how many standard deviations x is away of x.
- The variance is minimal at $x=\bar{x}$ We have $\hat{g}(x)$ $\frac{\hat{g}(x)}{S\sqrt{\frac{1}{n}+\frac{(x-\bar{x})^2}{S}}} \sim t_{n-2}$

- confidence interval for Bo+ Bi-DC:

- If we calculate this woross all x

